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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/722,033	MIYANO ET AL.		
Examiner .	Art Unit		
Pablo Whaley	1631		

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SEARCH N (INCLUDING SEARC		)
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Dialog and EAST search: See attached	9/8/2006	PW
Inventor Search: PALM	9/8/2006	PW
Priority search: PALM	9/8/2006	PW
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